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 Multimedia, IEEE ,Volume: 4 , Issue: 2 , April-June 1997
 Pages:46 - 57

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2 Frequency analysis of gradient estimators in volume rendering
Bentum, M.J.; Lichtenbelt, B.B.A.; Malzbender, T.;
 Visualization and Computer Graphics, IEEE Transactions on ,Volume: 2 , Issu
 3 , Sept. 1996
 Pages:242 - 254

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3 A histogram-based color consistency test for voxel coloring
Stevens, M.R.; Culbertson, B.; Malzbender, T.;
 Pattern Recognition, 2002. Proceedings. 16th International Conference on
 ,Volume: 4 , 2002
 Pages:118 - 121 vol.4

[\[Abstract\]](#) [\[PDF Full-Text \(533KB\)\]](#) **IEEE CNF**
4 Opacity-weighted color interpolation for volume sampling
Wittenbrink, C.M.; Malzbender, T.; Goss, M.E.;
 Volume Visualization, 1998. IEEE Symposium on , 19-20 Oct. 1998
 Pages:135 - 142, 177

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Alexandrov, I.; Amorim, A.; Badescu, E.; Barczyk, M.; Burckhart-Chromek, D.; Caprini, M.; Conceicao, J.D.S.; Flammer, J.; Di Girolamo, B.; Dobson, M.; Har Jones, R.; Kazarov, A.; Kolos, S.; Kotov, V.; Klose, D.; Liko, D.; Lima, J.; Luc. Mapelli, L.; Mineev, M.; Pedro, L.; Ryabov, Y.; Soloviev, I.; Wolters, H.; Nuclear Science, IEEE Transactions on ,Volume: 51 , Issue: 3 , June 2004 Pages:578 - 584

[\[Abstract\]](#) [\[PDF Full-Text \(736KB\)\]](#) IEEE JNL
2 Process Management inside ATLAS DAQ

Alexandrov, I.; Amorim, A.; Badescu, E.; Burckhart-Chromek, D.; Caprini, M.; Dobson, M.; Duval, P.Y.; Hart, R.; Jones, R.; Kazarov, A.; Kolos, S.; Kotov, V. Liko, D.; Lucio, L.; Mapelli, L.; Mineev, M.; Moneta, L.; Nassiakou, M.; Pedro, Ribeiro, A.; Roumiantsev, V.; Ryabov, Y.; Schweiger, D.; Soloviev, I.; Wolters Nuclear Science, IEEE Transactions on ,Volume: 49 , Issue: 5 , Oct. 2002 Pages:2459 - 2462

[\[Abstract\]](#) [\[PDF Full-Text \(197KB\)\]](#) IEEE JNL
3 Use of CORBA in the ATLAS prototype DAQ

Amorim, A.; Badescu, E.; Burckhart, D.; Caprini, M.; Cohen, L.; Duval, P.-Y.; Jones, B.; Kolos, S.; Mapelli, L.; Michelotto, M.; Nacasch, R.; Zuxuan Qian; R. A.; Ryabov, Y.; Soloviev, I.; Wheeler, S.; Wildish, T.; Wolters, H.; Nuclear Science, IEEE Transactions on ,Volume: 45 , Issue: 4 , Aug. 1998 Pages:1978 - 1982

[\[Abstract\]](#) [\[PDF Full-Text \(424KB\)\]](#) IEEE JNL
4 Electromagnetic simulation of a loaded cavity

Ehmann, R.; Burkhardt, M.; Wolter, H.; Weiland, T.; Magnetics, IEEE Transactions on ,Volume: 32 , Issue: 3 , May 1996 Pages:922 - 925

[\[Abstract\]](#) [\[PDF Full-Text \(300KB\)\]](#) IEEE JNL

5 Field-based analysis of a high pincount board connector

Wolter, H.; Katzier, H.; Podebrad, O.; Weiland, T.;

Components, Packaging, and Manufacturing Technology, Part B: Advanced Packaging, IEEE Transactions on [see also Components, Hybrids, and Manufacturing Technology, IEEE Transactions on] ,Volume: 19 , Issue: 1 , Fe 1996

Pages:23 - 31

[\[Abstract\]](#) [\[PDF Full-Text \(1188KB\)\]](#) IEEE JNL

6 Broadband calculation of scattering parameters in the time domain

Wolter, H.; Dohlus, M.; Weiland, T.;

Magnetics, IEEE Transactions on ,Volume: 30 , Issue: 5 , Sep 1994

Pages:3164 - 3167

[\[Abstract\]](#) [\[PDF Full-Text \(252KB\)\]](#) IEEE JNL

7 Process management inside ATLAS DAQ

Alexandrov, I.; Amorim, A.; Badescu, E.; Burckhart-Chromek, D.; Caprini, M.; Dobson, M.; Duval, P.Y.; Hart, R.; Jones, R.; Kazarov, A.; Kolos, S.; Kotov, V. Liko, D.; Lucio, L.; Mapelli, L.; Mineev, M.; Moneta, L.; Nassiakou, M.; Pedro, Ribeiro, A.; Roumiantsev, V.; Ryabov, Y.; Schweiger, D.; Soloviev, I.; Wolters Nuclear Science Symposium Conference Record, 2001 IEEE ,Volume: 1 , 4-10 Nov. 2001

Pages:511 - 514 vol.1

[\[Abstract\]](#) [\[PDF Full-Text \(269KB\)\]](#) IEEE CNF

8 Theoretical analysis of human muscle membrane behavior in hypokalemic periodic paralysis

Alberink, M.J.; Wallinga, W.; Wolters, H.; Ypey, D.L.; Links, T.P.; Boom, H.B. Engineering in Medicine and Biology Society, 1995. IEEE 17th Annual Conference ,Volume: 2 , 20-23 Sept. 1995

Pages:1493 - 1494 vol.2

[\[Abstract\]](#) [\[PDF Full-Text \(172KB\)\]](#) IEEE CNF

9 Field-based analysis of a high pincount board connector

Wolter, H.; Katzier, H.; Podebrad, O.; Weiland, T.;

Electronic Components and Technology Conference, 1995. Proceedings., 45th 24 May 1995

Pages:144 - 149

[\[Abstract\]](#) [\[PDF Full-Text \(480KB\)\]](#) IEEE CNF

10 Mafia in Practice: the Capabilities of the Mafia Cad System

Bartsch, M.; Dehler, M.; Dohlus, M.; Ebeling, F.; Hahne, P.; Klatt, R.; Krawczyk, F.; Zhang Min; Propper, T.; Schmitt, D.; Schutt, P.; Weiland, T.; Wolter, H.; M. M.; Wipf, S.G.; Steffen, B.;

Electromagnetic Field Computation, 1992. Digest of the Fifth Biennial IEEE Conference on , August 3-5, 1992

Pages:MP53 - MP53

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Computer Graphics and Applications, 2003. Proceedings. 11th Pacific Conference on , 8-10 Oct. 2003

Pages:41 - 50

[\[Abstract\]](#) [\[PDF Full-Text \(523 KB\)\]](#) **IEEE CNF**
2 Time-variable-parametric relaxation labeling and its application in texture segmentation*Hun-Tao Qian; Qi Wang; Suen, C.Y.;*

Machine Learning and Cybernetics, 2002. Proceedings. 2002 International Conference on , Volume: 1 , 4-5 Nov. 2002

Pages:486 - 491 vol.1

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3 Empirical calibration method for adding colour to range images*Robertson, C.; Fisher, R.B.;*

3D Data Processing Visualization and Transmission, 2002. Proceedings. First International Symposium on , 19-21 June 2002

Pages:558 - 561

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4 Size preserving pattern mapping*Kurzion, Y.; Moller, T.; Yagel, R.;*

Visualization '98. Proceedings , 18-23 Oct. 1998

Pages:367 - 373, 552

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